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Citation: Appl. Phys. Lett. **94**, 142108 (2009); doi: 10.1063/1.3116120

View online: http://dx.doi.org/10.1063/1.3116120

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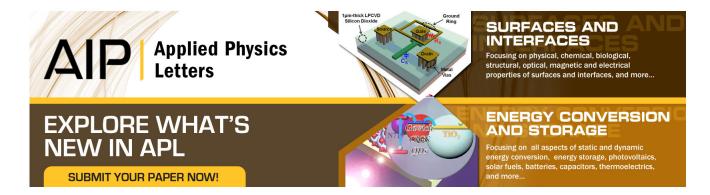
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Superconductivity in heavily compensated Mg-doped InN

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(Received 10 February 2009; accepted 11 March 2009; published online 10 April 2009)

We report superconductivity in Mg-doped InN grown by molecular beam epitaxy. Superconductivity phase transition temperature occurs T_c =3.97 K as determined by magnetoresistance and Hall resistance measurements. The two-dimensional (2D) carrier density of the measured sample is $n_{\rm 2D}$ =9×10¹⁴ cm⁻² corresponding to a three-dimensional (3D) electron density of $n_{\rm 3D}$ =1.8×10¹⁹ cm⁻³ which is within the range of values between Mott transition and the superconductivity to metal transition. We propose a plausible mechanism to explain the existence of the superconductivity in terms of a uniform distribution of superconducting InN nanoparticles or nanosized indium dots forming microscopic Josephson junctions in the heavily compensated insulating bulk InN matrix. © 2009 American Institute of Physics. [DOI: 10.1063/1.3116120]

Until about a couple of decades ago the commonly accepted value for the InN band gap energy was 1.89 eV. However, the recent progress in epitaxial growth techniques has led to the availability of high quality InN yielding strong experimental evidence to show that the real band gap energy of InN is between 0.7 and 0.8 eV at room temperature.² This value is close to recent theoretical calculations. This observation had two important implications: first, many theoretical studies and experimental explanations based on the previously reported InN gap of 1.89 eV had to be revised; second, as the wurtzite structured InN forms an alloy with GaN it became possible to form indium-rich ternary GaInN. Indium-rich GaInN can be utilized in optoelectronic device applications extending the well-known ultraviolet and blue spectral region applications of the Ga rich material to the near infrared, thus covering wavelengths from 200 to 1650 nm using a single material system.^{6–11}

There is little experimental data on the electrical properties of InN particularly at low temperatures. Recently, Inushima et al. 12 has reported the observation of superconducting behavior of InN. This is followed by other reports from the same group 13-18 including the measurements of superconductivity transition temperature as a function of carrier density. A range of possible mechanisms to explain the transition has been explored by various research groups. Inushima et al. 17 proposed that superconductivity is related to the presence of the In-In chains of finite length spread in the ab-plane. Recently it was reported that Si-doped InN with the carrier density between 2×10^{18} and 1.5×10^{19} cm⁻³ did not show superconductivity. 18 This inhibition of superconductivity was interpreted in terms of the range of carrier densities imposing a limit on the transition. However, this range of carrier densities was challenged by Inushima et al., 17 where it was reported that the lowest carrier density is limited by the Mott transition which is about 2×10^{17} cm⁻³,

and the highest density is limited by the superconductivity to metal transition at about 7×10^{20} cm⁻³.

Ling *et al.*¹⁹ reported superconductivity behavior in metal organic vapor phase epitaxy (MOVPE) grown InN samples supporting the interpretation of Inushima *et al.*¹⁷ that the superconductivity was due to the presence of In–In chains of finite length in the *ab*-plane. More recently, Kadir *et al.*²⁰ proposed an alternative mechanism in MOVPE grown material where they claimed the anisotropic and type II superconductivity to be associated with the presence of In₂O₃ impurities formed during the annealing process.²⁰ X-ray diffraction data indicated that the observed In₂O₃ impurities may be the reason for the phase transition as indium oxide is a well-known superconductor at T_c =3.2 K in granular and amorphous form.²⁰ They reported superconductive transition at temperatures between T_c =3.1 and 0.5 K depending on the indium oxide concentration.

No consensus have, however, emerged to date about underlying physical mechanism for superconductivity in InN and it is worth pointing out that no observation of superconductivity has been reported in either In-rich GaInN or Mgdoped InN. Present work presented here is concerned with the study of superconductivity in Mg-doped heavily compensated InN.

The Mg-doped InN films were grown by a Varian GEN-II gas-source molecular beam epitaxy (MBE) on *c-sapphire* substrates with a roughly 200 nm thick GaN buffer layer. The thickness of the InN layer as determined from growth parameters and verified by backscattering spectrometry was nearly 500 nm. The Mg concentration, as measured by secondary ion mass spectroscopy, ranged from 2×10^{20} to 1×10^{21} cm⁻³. A nominally undoped InN film was used as a standard for comparison; it was a 2700 nm thick InN film with a 300 nm thick GaN buffer layer. The Mg-doped InN (GS1548) and undoped InN (GS1382) samples were fabricated in Hall-bar geometry and Ohmic contacts were formed by diffusing the Au/Ni alloy. At low temperatures the two-dimensional (2D) electron densities

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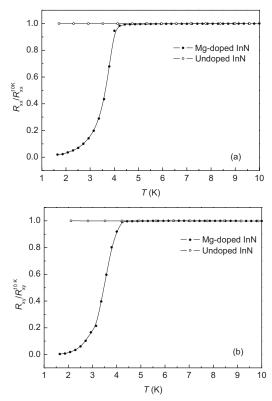


FIG. 1. The temperature dependence of the (a) R_{xx} and (b) R_{xy} both normalized with respect to their 10 K value for Mg-doped and undoped InN samples.

were $n_{\rm 2D}$ =1.3×10¹⁴ and 9×10¹⁴ cm⁻² in the undoped and Mg-doped material, respectively.

The resistance (R_{xx}) along the applied current and Hall resistance (R_{xy}) measurements were carried out as a function of (i) temperature at fixed magnetic and electric fields where the electric field was kept low enough to ensure Ohmic conditions, hence to avoid carrier heating and, (ii) as a function of magnetic field at a fixed electric field and at the lowest of the temperature range $(T \sim 1.6 \, \text{K})$. The R_{xx} and R_{xy} measurements were performed in a four terminal configuration in a cryogen free superconducting magnet system.

In this study, the dramatic reduction in the electrical resistivity, within about 1 K temperature interval, from 246 to 4.7 Ω for R_{xx} are attributed to transition to superconducting state (where the latter figure includes the lead resistances). Phase transition from the semiconducting state to superconducting state occurs at $T \le 3.97$ K.

In Fig. 1 we show the sample resistance in a direction parallel and perpendicular to the current flow for both an undoped InN with a very high electron density and in Mgdoped InN. It is clear from the figure that there is no evidence of superconductivity in the undoped (heavily *n*-type) material while the Mg-doped material exhibits superconductivity.

It has been claimed generally in the literature that the superconductivity in InN is anisotropic and type II. $^{12-17,19}$ Our sample also showed an anisotropic superconductivity. Figure 2 shows the clear evidence of the anisotropy in the upper critical magnetic field parallel and perpendicular to the c-axis. The angle-dependent threshold applied field values at which transitions occur are H_{c1} and H_{c2} . Under the limitations in our experimental setup we could not obtain H_{c1} . However H_{c2} values are 0.3410 and 1.2 T for the $B \parallel c$ -axis,

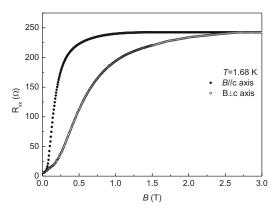


FIG. 2. Magnetic field dependence of R_{xx} at T=1.68 K.

and $B \perp c$ -axis, respectively. These values are much greater than the critical magnetic field of In which is 0.023 T. This observation alone may suggest that it is bulk InN rather than In dots/chains that become superconductive. If it is InN becoming superconducting two equally plausible mechanisms may explain the observed behavior. First the metallic 2D InN with a large density of electron accumulation at the surface ⁹⁻¹¹ may, at low temperatures, become a 2D superconducting channel shorting completely the bulk conduction. If this is the case we should also be able to observe the semiconductor-superconductor transition in undoped InN. As we have shown in Fig. 1, there is no evidence for superconductivity in the undoped InN down to our lowest measurement temperatures of $T \le 1.68$ K. The second possibility is the existence of either indium or metallic InN nanoparticles (quantum dots?) distributed in the heavily compensated InN matrix in the bulk of the material. In this case when the temperature is low enough for the heavily compensated InN to become an insulator and at the same time InN or In quantum dots to become superconducting we may then expect the formation of microscopic Josephson junctions that are distributed in the bulk of the sample. The transport then occurs via the superconducting tunneling at low enough applied voltages, and this shorts out the 2D conductivity at the surface. Whether the quantum dots (nanoparticles) are indium or InN cannot be determined from the magnetotransport experiments alone, but may be understood tentatively from the observation of the H_{c2} values of 0.3410 and 1.2 T being much greater than the critical magnetic field of metal indium which is 0.023 T (Ref. 14) suggesting that it is InN rather

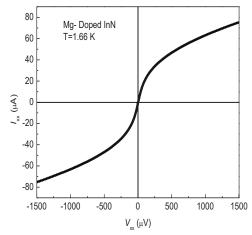


FIG. 3. Current-voltage (I-V) measurements at T=1.66 K.

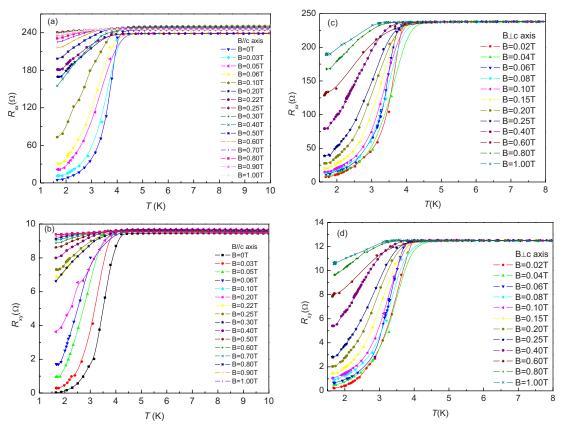


FIG. 4. (Color online) The temperature dependence of R_{xx} and R_{xy} at fixed magnetic field. Magnetic field direction was parallel to c-growth axis in (a) and (b) and perpendicular in (c) and (d).

than indium dots that become superconductive as explained

In Fig. 3 we show the current-voltage measurements of the Mg-doped samples at $T=1.66\,\mathrm{K}$. Up to an applied voltage of $V_{xx} < 100 \mu V$ we observe a behavior similar to an isolated Josephson junction (in our case it is largely smeared out due to a distribution of large number of junctions in the host matrix). At $V_{xx} > 100 \mu V$ current has tendency toward saturation. It is clear that at the measurement temperature (T=1.66 K) which is well below the transition temperature a small applied voltage of 100 μ V breaks the superconductivity behavior.

Another interesting observation in the temperature dependence of the resistance is the shape of the superconducting phase transition. It is clear from Fig. 4 that with increasing applied magnetic field, the shape of the R_{xx} and R_{xy} versus temperature curve in the superconducting state changes from convex to concave at H_{c2} values for both $B \parallel c$ -axis and $B \perp c$ -axis orientations. This observation indicates that the vortex dynamics of our InN samples are different from high-temperature superconductors.¹³

E.T. acknowledges the financial support of TUBITAK Ankara (Contract No. EEEAG-105E076) and Anadolu University (Contract No. 051023).

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